



Resistor Product Discontinuation & Update

We would like to take this opportunity to thank you for your patronage and the many years of support you have given to our resistive products. As you know we are de-emphasizing the product line and would like to inform you of our decision to re-align our product offering.

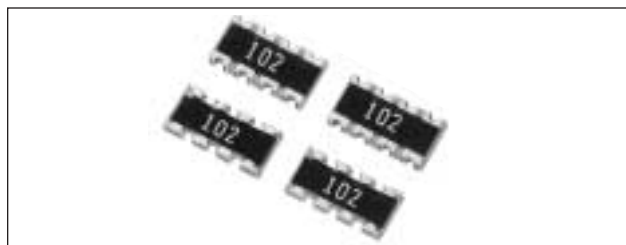
AVX will expand our focus on our 0408 and smaller resistor array products and discontinue to offer our larger case size resistor chip series along with the 1206 resistor arrays. This will be accomplished in several stages over the next twelve months. Please refer to each product series below and the effective dates we will cease to supply the products.

- **Chip Resistor Series (CR63, CR32, CR21, CR10)**
Final Ship Date: February 1st, 2004
- **Chip Resistor Series (CR05)**
Final Ship Date: August 1st, 2004
- **1206 Resistor Array Series (CRA3A4E, CRB3A4E, CRC3A4E)**
Final Ship Date: August 1st, 2004

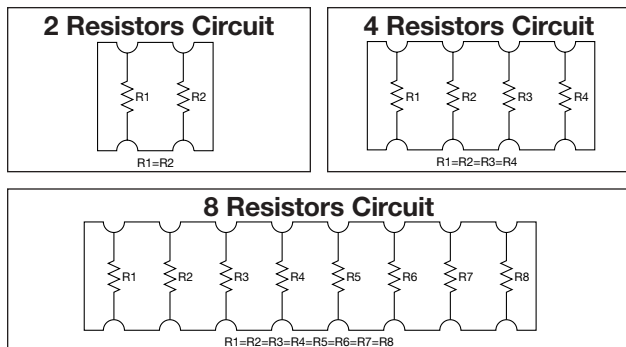
We would like to work closely with you during the discontinuation period and minimize any inconveniences that may arise. Should you have any questions or comments, please contact KDP Marketing.

Chip Resistor Arrays

CRB Series (Concave Type)



Chip Resistor Arrays have several resistor elements integrated as a single component.



RATING

Chip Resistor Arrays	
Item	Rating
Rated Power (70°C)*	1/16W Element
Max. Working Voltage	50V
Max. Overload Voltage	100V
Resistance Value	10Ω to 2.2MΩ (CRB6A 1MΩ max.)
Tolerance	J±5% (CRB6A G ± 2% only)
Working Temperature	-55 to +125°C

*Rated voltage = 50V or $\sqrt{\text{Rated power} \times \text{Resistance value}}$, whichever is less

DIMENSIONS

CRB1A2E

Technical drawing of the CRB1A2E chip. The top view shows a rectangular chip with a central rectangular area of width 'a' and length 'L'. The total width is 'W' and the total length is 'L'. The chip has a thickness 't' and a central hole of diameter 'd'. The distance from the center of the hole to the edge is 'C'. The distance from the center of the hole to the edge of the central area is 'b'. The distance from the center of the hole to the edge of the chip is 'P'.

Code	W	L	C	d	t	a	b	P
Dim.	1.60±0.15 (0.063±0.006)	1.60±0.20 (0.063±0.008)	0.30±0.20 (0.012±0.008)	0.40±0.15 (0.016±0.006)	0.60±0.10 (0.024±0.006)	0.50±0.15 (0.020±0.006)	0.30±0.10 (0.012±0.004)	0.80±0.10 (0.031±0.004)

No Marking on chips

CRB2A4E

Technical drawing of the CRB2A4E chip. The top view shows a rectangular chip with a central rectangular area of width 'a' and length 'L'. The total width is 'W' and the total length is 'L'. The chip has a thickness 'T' and a central hole of diameter 'd'. The distance from the center of the hole to the edge is 'C'. The distance from the center of the hole to the edge of the central area is 'b'. The distance from the center of the hole to the edge of the chip is 'P'.

Code	L	W	T	P	b	c	d	e
Dim.	2.00±0.10 (0.079±0.004)	1.00±0.10 (0.039±0.004)	0.40±0.10 (0.016±0.004)	0.50 typ (0.020 typ)	ø0.15 typ (ø0.006 typ)	0.20±0.15 (0.008±0.006)	0.25±0.015 (0.010±0.006)	0.25 typ (0.010 typ)

CRB3A4E

Technical drawing of the CRB3A4E chip. The top view shows a rectangular chip with a central rectangular area of width 'a' and length 'L'. The total width is 'W' and the total length is 'L'. The chip has a thickness 'T' and a central hole of diameter 'd'. The distance from the center of the hole to the edge is 'C'. The distance from the center of the hole to the edge of the central area is 'D'. The distance from the center of the hole to the edge of the chip is 'P'.

Code	W	L	C	D	T	P
Dim.	1.60±0.15 (0.063±0.006)	3.20±0.15 (0.126±0.006)	0.30±0.20 (0.012±0.008)	0.40±0.15 (0.016±0.006)	0.60±0.10 (0.024±0.004)	0.80 typ (0.031 typ)

CRB6A8E

Technical drawing of the CRB6A8E chip. The top view shows a rectangular chip with a central rectangular area of width 'a' and length 'L'. The total width is 'W' and the total length is 'L'. The chip has a thickness 'T' and a central hole of diameter 'd'. The distance from the center of the hole to the edge is 'C'. The distance from the center of the hole to the edge of the central area is 'c'. The distance from the center of the hole to the edge of the chip is 'P'. The distance from the center of the hole to the edge of the chip is 'e (top)' and 'e (bottom)'.

Code	L	W	T	P	c	d	e (top)	e (bottom)
Dim.	6.40±0.20 (0.252±0.008)	1.60±0.20 (0.063±0.008)	0.60±0.10 (0.024±0.004)	0.80 typ (0.031 typ)	0.30±0.20 (0.012±0.008)	0.40±0.15 (0.016±0.006)	0.50±0.10 (0.020±0.004)	0.40±0.15 (0.016±0.006)

Detailed specifications are available on request.

FEATURES

- Reduction in mounting process & costs
- Save PCB space
- Reduction of inventory control costs

APPLICATIONS

- Computer
- Hard Disk Drive
- Printer
- CD-ROM

HOW TO ORDER

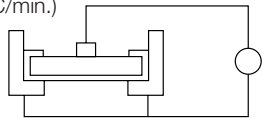
CRB	1A	2E	103	J	T
Series					
Size	1A = 0606 size 2A = 0804 size 3A = 1206 size 6A = 2506 size				
Number of Elements	2E = 2 Elements 4E = 4 Elements 8E = 8 Elements				
				Packaging T = Paper Taping • CRB1A 10,000 pcs/7" reel • CRB2A 10,000 pcs/7" reel • CRB3A 5,000 pcs/7" reel U = Plastic Taping • CRB6A 4,000 pcs/7" reel	
				Resistance Tolerance J = ±5% G = ±2% Blank = Chip Jumper Arrays	
				Resistance Value (3 digits) Chip Jumper Arrays = 000	

Chip Resistor Arrays



CR, CJ, CRA, CRB, CRC Series - Test Conditions

ELECTRICAL CHARACTERISTICS

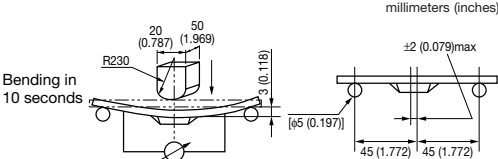
Item		Standard		Test Conditions							
		Resistor	Jumper	Resistor	Jumper						
DC Resistance		Within Initial Tolerance		Power Condition A (20°C, 65% RH)							
Temperature Characteristics		<table><tr><th>Resistance (Ω)</th><th>TCR (ppm/°C)</th></tr><tr><td>*D, F 10≤ R ≤1M</td><td>-100 to +100</td></tr><tr><td>J, CR05 = F R <10 10≤ R ≤1M 1M< R</td><td>-100 to +600 -250 to +250 -500 to +300</td></tr></table>	Resistance (Ω)	TCR (ppm/°C)	*D, F 10≤ R ≤1M	-100 to +100	J, CR05 = F R <10 10≤ R ≤1M 1M< R	-100 to +600 -250 to +250 -500 to +300		Test Temperature: 25, 125(°C) ΔR/R=R₂–R₁/R₁×1/T₂–T₁×10⁶ ΔR/R = Temp. Coefficient (ppm/°C) T₁ = 25(°C) T₂ = 125(°C) R₁ = T₁ Resistance at (Ω) R₂ = T₂ Resistance at (Ω)	
Resistance (Ω)	TCR (ppm/°C)										
*D, F 10≤ R ≤1M	-100 to +100										
J, CR05 = F R <10 10≤ R ≤1M 1M< R	-100 to +600 -250 to +250 -500 to +300										
Short-time Overload	ΔR/R	±(2.0%+0.10Ω) max. of the initial value	50mΩ max.	(1) Apply 2.0 x rated voltage for 5 sec. (2.5 x rated voltage for Arrays) (2) Wait 30 minutes (3) Measure resistance CR03 = 30V max. CR05 = 50V max. CR10 = 100V max. CR21 = 200V max. CR32 = 400V max. CRA3A, CRB3A, CRC3A = 100V max.	(1) 2A for 5 sec. (CJ03 = 1A) (2) Wait 30 minutes (3) Measure resistance						
	Visual	No evidence of mechanical damage intermittent overload									
Intermittent Overload	ΔR/R	±(5%+0.1Ω) max. of the initial value	50mΩ max.	(1) Perform 10,000 voltage cycles as follows: ON (2.0 x rated voltage, 2.5 x for Arrays) 1 sec. OFF 25 sec. (2) Stabilization time 30 min. without loading (3) Measure resistance CR03 = 30V max. CR05 = 50V max. CR10 = 150V max. CR21 = 200V max. CR32 = 400V max. CRA, CRB, CRC = 100V max.	(1) Perform 10,000 current cycles as follows: ON (2A) 1 sec. OFF 25 sec. (2) Wait 30 minutes (3) Measure resistance CJ03 = 1A max.						
	Visual	No evidence of mechanical damage									
Dielectric Withstanding Voltage		No evidence of mechanical damage		Apply 500 VAC for 1 min. (CR10 300 VAC) (CR05, CRA3A, CRB3A, CRC3A 300 VAC/1 sec. CR03 50 VAC/min.)							
Insulation Resistance		• CR03, CJ03 = 10⁸Ω min. • CR05, CJ05 = 10⁸Ω min. • CR10, CJ10 = 10⁹Ω min. • CR21, CJ21 = 10¹⁰Ω min. • CR32, CJ32 = 10¹²Ω min. • CRA3A, CRB3A, CRC3A = 10⁹Ω min.		Apply 500V DC (CR05, CRA3A, CRB3A, CRC3A 100V DC CR03 50 VDC) 							

Chip Resistor Arrays



CR, CJ, CRA, CRB, CRC Series - Test Conditions

MECHANICAL CHARACTERISTICS

Item		Standard		Test Conditions	
		Resistor	Jumper	Resistor	Jumper
Terminal Strength	$\Delta R/R$	$\pm(1\%+0.05\Omega)$ max. of the initial value	50m Ω max.	Apply the load as shown: Measure resistance during load application	
	Visual	No evidence of mechanical damage after loading		 PC Board = Glass epoxy t = 1.60 (0.063)	
Soldering Heat Resistance	$\Delta R/R$	$\pm(1\%+0.05\Omega)$ max. of the initial value	50m Ω max.	Immerse into molten solder at $260\pm 5^{\circ}\text{C}$ for 10 ± 1 sec. Stabilize component at room temperature for 1 hr. Measure resistance.	
	Visual	No evidence of leaching			
Solderability		Coverage $\geq 95\%$ each termination end		Immerse in Rogin Flux for 2 ± 0.5 sec. and in SN62 solder at $235\pm 5^{\circ}\text{C}$ for 2 ± 0.5 sec.	
Anti-Vibration Test	$\Delta R/R$	$\pm(1\%+0.1\Omega)$ max. of the initial value	50m Ω max.	2 hrs. each in X, Y and Z axis. (TTL 6 hrs.) 10 to 55 Hz sweep in 1 min. at 1.5mm amplitude.	
	Visual	No evidence of mechanical damage			
Solvent Resistance	$\Delta R/R$	$\pm(0.5\%+0.05\Omega)$ max. of the initial value	50m Ω max.	Immerse in static state butyl acetate at 20°C to 25°C for 30 ± 5 sec. Stabilize component at room temperature for 30 min. then measure value.	
	Visual	No evidence of mechanical damage			

ENVIRONMENTAL CHARACTERISTICS

Item		Standard		Test Conditions	
		Resistor	Jumper	Resistor	Jumper
Temperature Cycle	ΔR/R	±(1%+0.05Ω) max. of the initial value	50mΩ max.	(1) Run 5 cycles as follows: -55±3°C for 30 min. 125±3°C for 30 min. Room temp. for 10-15 min. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Low Temperature Storage	ΔR/R	±(2%+0.1Ω) max. of the initial value	50mΩ max.	(1) Dwell in -55°C chamber without loading for 1000 ⁺⁴⁸ ₋₀ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
High Temperature Storage	ΔR/R	±(3%+0.1Ω) max. of the initial value	50mΩ max.	(1) Dwell in 125°C chamber without loading for 1000 ⁺⁴⁸ ₋₀ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Moisture Resistance	ΔR/R	±(3%+0.1Ω) max. of the initial value	50mΩ max.	(1) Dwell in temp.: 65°C RH90 to 95% RH chamber without loading for 1000 ⁺⁴⁸ ₋₀ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Life Test	ΔR/R	±(3%+0.1Ω) max. of the initial value	50mΩ max.	(1) Temp.: 70±3°C Voltage: (rated voltage) on 90 min. off 30 min. Duration: 1000 ⁺⁴⁸ ₋₀ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			
Loading Life in Moisture	ΔR/R	±(3%+0.1Ω) max. of the initial value	50mΩ max.	(1) Temp.: 40±2°C RH: 90-95% Voltage Cycle: on 90 min. (rated voltage) off 30 min. Duration: 1000 ⁺⁴⁸ ₋₀ hrs. (2) Stabilize component at room temperature for 1 hr. then measure value.	
	Visual	No evidence of mechanical damage			

Packaging of Chip Component

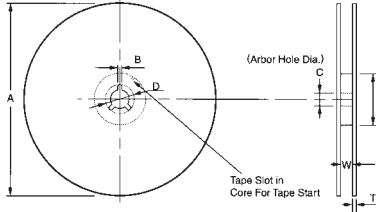


Automatic Insertion Packaging

TAPE AND REEL

REEL DIMENSIONS

millimeters (inches)

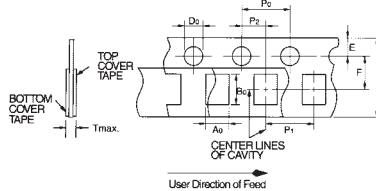


Tape Size	A Max.	B Min.	C	D Min.	N Min.	W	T Max.
8mm	178 (7)	1.50 (0.059)	13.0±0.50 (0.512±0.020)	20.2 (0.795)	50 (1.969)	10.0±1.50 (0.394±0.059)	2.50 (0.098)
	260 (10)						

Metric dimensions will govern.
English measurements rounded and for reference only.

millimeters (inches)

PUNCHED TAPE CONFIGURATION 8MM TAPE ONLY

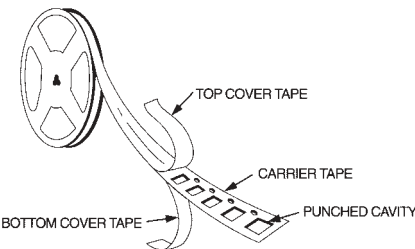


Tape Size	D ₀	E	P ₀	P ₂	W	F
8mm	1.50 ^{+0.10} / _{-0.00} (0.059 ^{+0.004} / _{-0.000})	1.75±0.10 (0.069±0.004)	4.0±0.10 (0.157±0.004)	2.00±0.05 (0.079±0.002)	8.00±0.20 (0.135±0.008)	3.50±0.05 (0.138±0.002)

VARIABLE DIMENSIONS

Style	P ₁	A ₀	B ₀	T max.
CR/CJ03 CR/CJ05	2.00±0.10 (0.079±0.004)	0.65±0.10 (0.026±0.004)	1.15±0.10 (0.045±0.004)	0.60 (0.024)
CR/CJ/FR10	4.00±0.10 (0.157±0.004) or 2.00±0.10 (0.079±0.004)	1.10±0.20 (0.043±0.008)	1.90±0.20 (0.075±0.008)	1.10 (0.043)
CR/CJ/FR21	4.00±0.10 (0.157±0.004)	1.65±0.20 (0.065±0.008)	2.40±0.20 (0.094±0.008)	
CR/CJ/FR32		2.00±0.20 (0.079±0.008)	3.60±0.20 (0.142±0.008)	
CRB1A		1.90±0.20 (0.075±0.008)	1.90±0.20 (0.075±0.008)	
CRA3A CRB3A CRC3A		2.00±0.20 (0.079±0.008)	3.60±0.20 (0.142±0.008)	
CRB2A	2.00±0.10 (0.079±0.004)	1.25±0.20 (0.049±0.008)	2.50±0.20 (0.098±0.008)	

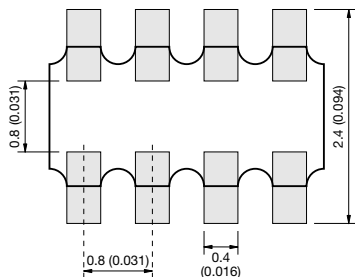
PUNCHED CARRIER



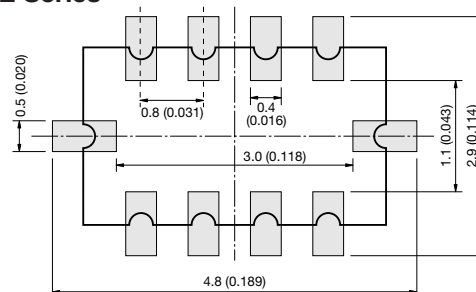
RECOMMENDED LAND PATTERNS IS REFERRED THE FOLLOWING FOR EXAMPLE

millimeters (inches)

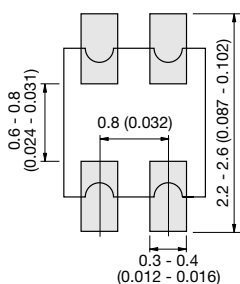
CRA3A4E Series



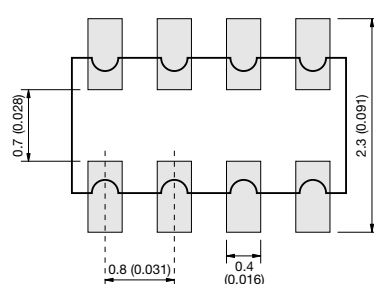
RNA4A8E Series



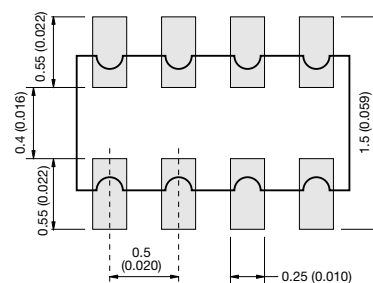
CRB1A2E Series



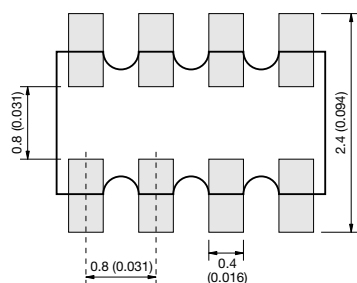
CRB3A4E Series



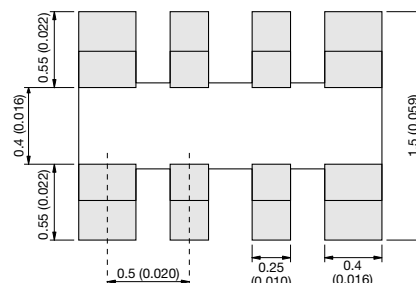
CRB2A4E Series



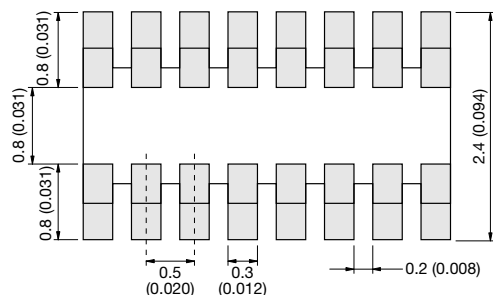
CRC3A4E Series



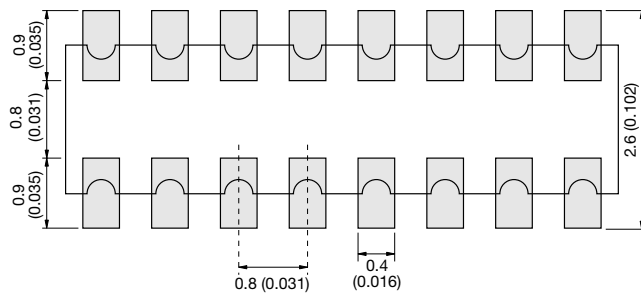
CRC2A4E Series



CRC4A8E Series



CRB6A8E Series



SAMPLE KIT PART NUMBERS

Part Number	Description
CRJ-E6-Kit	Combination 0603, 0805, 1206, 5% parts 21 values per case size 100 pcs. per value (approx.)
CR05-E12-Kit	0402, 5% parts 63 values 100 pcs. per value
CR10J-E12-Kit	0603, 5% parts 63 values 100 pcs. per value (approx.)
CR21J-E12-Kit	0805, 5% parts 63 values 100 pcs. per value (approx.)
CR32J-E12-Kit	1206, 5% parts 63 values 100 pcs. per value (approx.)
CR05F-E24-Kit	0402, 1% parts 63 values 100 pcs. per value
CR10F-E24-Kit	0603, 1% parts 63 values 100 pcs. per value
CR-ARRAY-E6-Kit	Arrays, Various styles, CRA, CRB, CRC, RNA, 5% 13 values per style (approx.) 20 pcs. per value